

Notice of References Cited	Application/Control No. 10/045,007		Applicant(s)/Patent Under Reexamination BEER ET AL.	
	Examiner Jason Mitchell		Art Unit 2193	Page 1 of 1

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	W	Esparza, Kucera, Schwoon "Model-Checking LTL with Regular Valuations for Pushdown Systems" Lecture Notes In Computer Science; Vol. 2215, 2001
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.